

RJH60T4DPQ-A0

Silicon N Channel IGBT
High Speed Power Switching

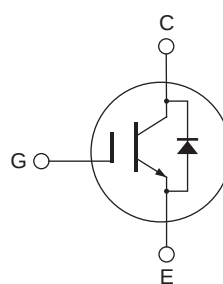
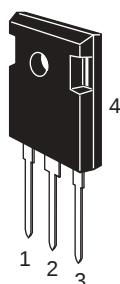
R07DS0460EJ0100
Rev.1.00
Jun 15, 2011

Features

- Low collector to emitter saturation voltage
 $V_{CE(sat)} = 1.7 \text{ V typ. (at } I_C = 30 \text{ A, } V_{GE} = 15 \text{ V, } T_a = 25^\circ\text{C)}$
- Built in fast recovery diode in one package
- Trench gate and thin wafer technology
- High speed switching

Outline

RENESAS Package code: PRSS0003ZH-A
(Package name: TO-247A)



1. Gate
2. Collector
3. Emitter
4. Collector

Absolute Maximum Ratings

($T_c = 25^\circ\text{C}$)

Item	Symbol	Ratings	Unit
Collector to emitter voltage	V_{CES}	600	V
Gate to emitter voltage	V_{GES}	± 30	V
Collector current	I_C ^{Note1}	60	A
	I_C ^{Note1}	30	A
Collector peak current	$i_{c(peak)}$ ^{Note1}	120	A
Collector to emitter diode forward peak current	$i_{DF(peak)}$ ^{Note2}	80	A
Collector dissipation	P_C	235.8	W
Junction to case thermal impedance (IGBT)	θ_{j-c}	0.53	$^\circ\text{C/W}$
Junction to case thermal impedance (Diode)	θ_{j-cd}	2.1	$^\circ\text{C/W}$
Junction temperature	T_j	150	$^\circ\text{C}$
Storage temperature	T_{stg}	-55 to +150	$^\circ\text{C}$

Notes: 1. Pulse width limited by safe operating area.
2. $PW \leq 5 \mu\text{s}$, duty cycle $\leq 1\%$

Electrical Characteristics

(T_j = 25°C)

Item	Symbol	Min	Typ	Max	Unit	Test Conditions
Zero gate voltage collector current	I _{CES}	—	—	100	μA	V _{CE} = 600V, V _{GE} = 0
Gate to emitter leak current	I _{GES}	—	—	±1	μA	V _{GE} = ±30 V, V _{CE} = 0
Gate to emitter cutoff voltage	V _{GE(off)}	4	—	8	V	V _{CE} = 10V, I _C = 1 mA
Collector to emitter saturation voltage	V _{CE(sat)}	—	1.7	2.2	V	I _C = 30 A, V _{GE} = 15V ^{Note3}
	V _{CE(sat)}	—	2.2	—	V	I _C = 60 A, V _{GE} = 15V ^{Note3}
Input capacitance	C _{ies}	—	1900	—	pF	V _{CE} = 25 V
Output capacitance	C _{oes}	—	93	—	pF	V _{GE} = 0 V
Reverse transfer capacitance	C _{res}	—	33	—	pF	f = 1 MHz
Switching time	t _{d(on)}	—	45	—	ns	I _C = 30 A, V _{CE} = 400 V, V _{GE} = 15 V R _g = 5 Ω ^{Note3} Inductive load
	t _r	—	86	—	ns	
	t _{d(off)}	—	85	—	ns	
	t _f	—	72	—	ns	
C-E diode forward voltage	V _{ECF}	—	1.2	1.6	V	I _F = 20 A ^{Note3}
C-E diode reverse recovery time	t _{rr}	—	100	—	ns	I _F = 10 A di _F /dt = -20 A/μs

Notes: 3. Pulse test